



Theory of Semiconductor Laser Cooling at Low Temperatures

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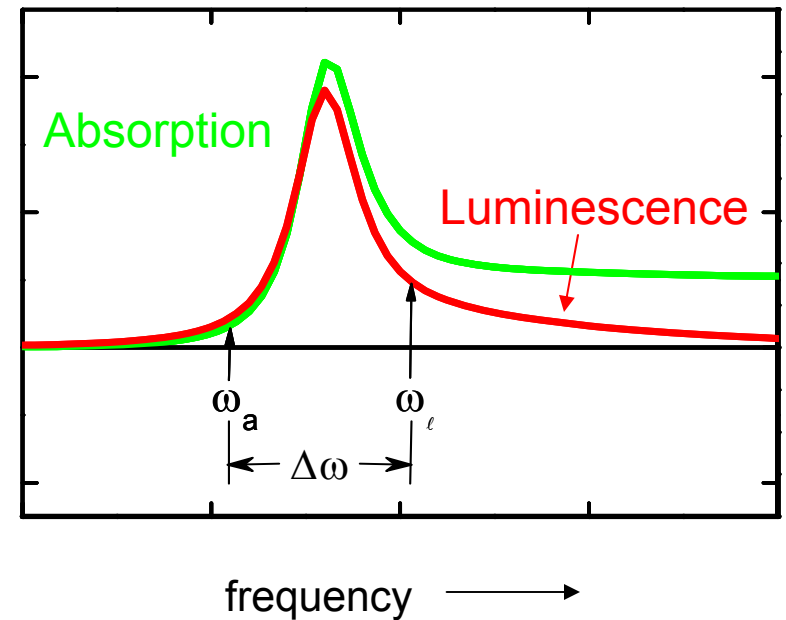
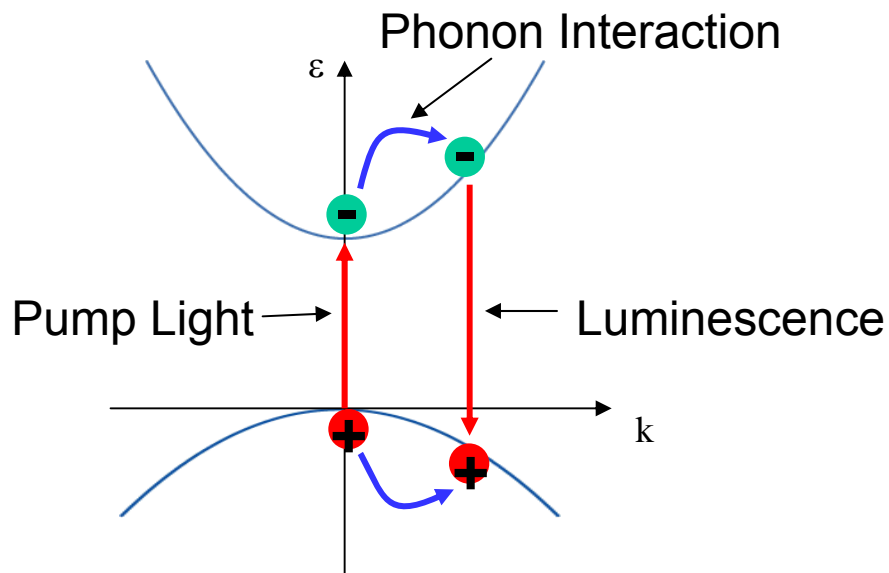
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Semiconductor: basic cooling principle

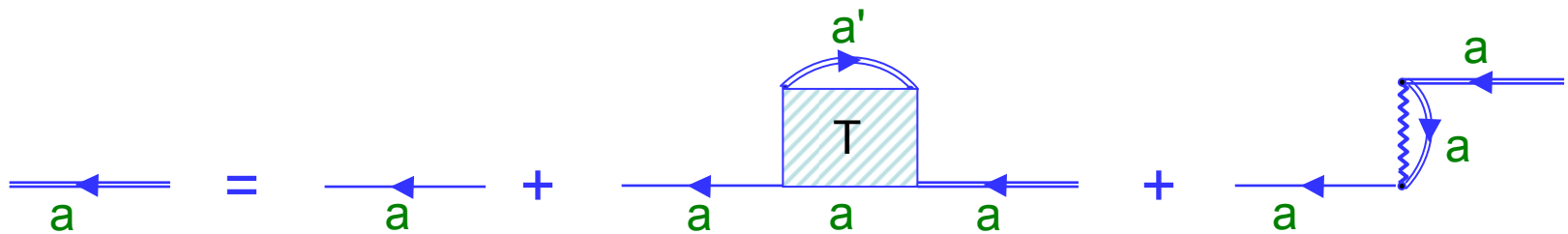
mean frequency of emitted light higher than absorbed light

 energy removed from semiconductor





Dyson equation (\Leftrightarrow quasi-particles, energy renormalization, damping and dephasing, chemical potential, density, ionization degree)



T-selfenergy includes electron bound to hole as exciton

quasi-statically screened Hartree-Fock selfenergy
+
Coulomb hole selfenergy

T-matrix (\Leftrightarrow non-perturbative e-h, e-e, h-h correlation)





Cooling analysis

$$P_{net} = I \left[\alpha(\omega_a, n) + \alpha_b + \sigma_{fca} n \right] - \hbar\omega_e \eta_e B(n) n^2$$

$$\frac{dn}{dt} = \frac{\alpha(\omega_a, n)}{\hbar\omega_a} I - An - \eta_e B(n) n^2 - Cn^3 = 0$$

absorption

luminescence

from microscopic theory

An - Non-radiative recombination rate

Cn^3 - Auger recombination rate

Bn^2 - Radiative recombination rate

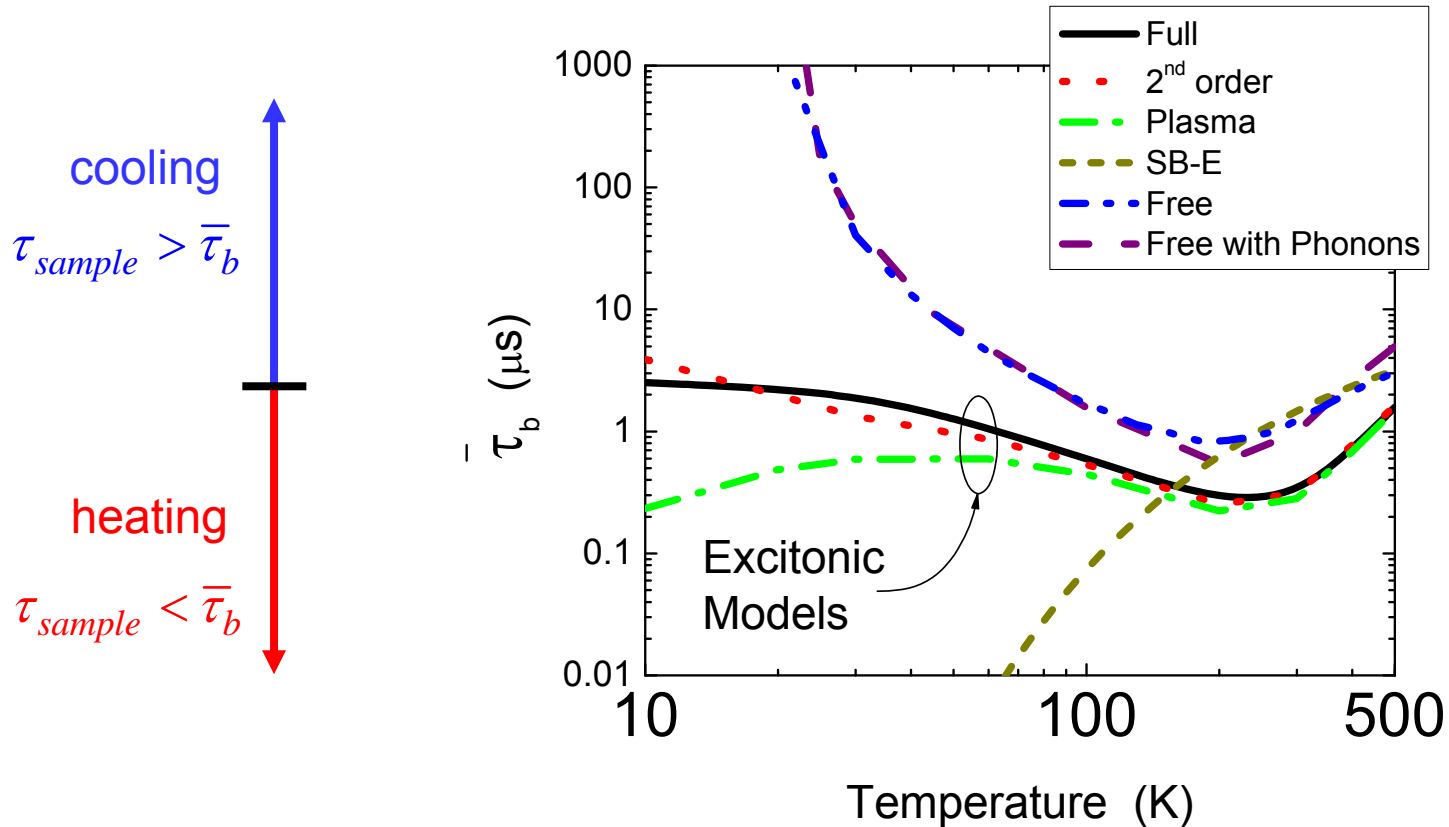
α_b - Parasitic background absorption

η_e - Extraction efficiency

σ_{fca} - Free carrier absorption



Threshold non-radiative lifetime



Rupper, Kwong, Binder, Phys. Rev. Lett. 97, 117401 (2006)

Rupper, Kwong, Binder, Phys. Rev. B 76, 245203 (2007)

Rupper, Kwong, Binder, Phys. Rev. B 79, 155205 (2009)